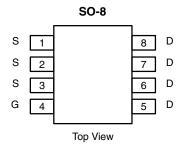


Vishay Siliconix

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω) (Max.)	I _D (A) ^a	Q _g (Typ.)			
30	0.0034 at V _{GS} = 10 V	31.3	22.5 nC			
30	0.0044 at V _{GS} = 4.5 V	27.5	22.3110			



Ordering Information:

Si4010DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

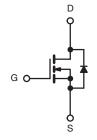
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

Material categorization:
 For definitions of compliance please see www.vishav.com/doc?99912



APPLICATIONS

- Synchronous Rectification
- DC/DC Conversion
- Telecom/Server
- Industrial



N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30		
Gate-Source Voltage		V _{GS}	+ 20, - 16	V	
	T _C = 25 °C		31.3		
Continues Durin Comment /T. 150 °C)	T _C = 70 °C	1 .	24.9		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	20.2 ^{b, c}		
	T _A = 70 °C		16.1 ^{b, c}	•	
Pulsed Drain Current (t = 300 μs)		I _{DM}	100	A	
Continuous Course Ducie Diede Courset	T _C = 25 °C		5.4		
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	2.2 ^{b, c}		
Single Pulse Avalanche Current	1 04	I _{AS}	20		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	20	mJ	
	T _C = 25 °C		6		
Martin or Broad State of the	T _C = 70 °C		3.8	147	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	W	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R_{thJA}	37	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	17	21	C/VV		

Notes

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 85 °C/W.



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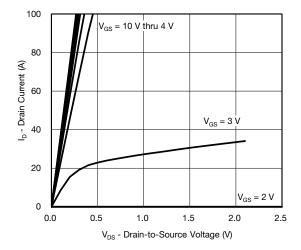
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static	Cymbol	rest conditions		i yp.	IVIUX	Onic	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			14			
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J	I _D = 250 µA		- 5.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1		2.3	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = + 20 V, - 16 V			± 100	nA	
		V _{DS} = 30 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	40			Α	
		V _{GS} = 10 V, I _D = 15 A		0.0028	0.0034	Ω Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.0035	0.0044		
Forward Transconductancea	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		105		S	
Dynamic ^b						l	
Input Capacitance	C _{iss}			3595		pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1040			
Reverse Transfer Capacitance	C _{rss}	1		79			
Total Cata Chausa		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		51	77	nC	
Total Gate Charge	Q_g			22.5	34		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		8.6			
Gate-Drain Charge	Q _{gd}	1		4			
Output Charge	Q _{oss}	V _{DS} = 15 V, V _{GS} = 0 V		30.5			
Gate Resistance	R_g	f = 1 MHz	0.5	1.25	2	Ω	
Turn-On Delay Time	t _{d(on)}			24	48		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		17	34		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 10$ A, $V_{GEN}=4.5$ V, $R_g=1$ Ω		25	50		
Fall Time	t _f	1		12	24		
Turn-On Delay Time	t _{d(on)}			12	24	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		10	20]	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 1.5 \text{ V}, R_g = 1 \Omega$		30	60		
Fall Time	t _f			9	18		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.4	_	
Pulse Diode Forward Current	I _{SM}				100	Α	
Body Diode Voltage	V _{SD}	I _S = 5 A,		0.73	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			36	70	ns	
Body Diode Reverse Recovery Charge	Q _{rr}] 10 A dl/dt 100 A/:- T 05 00		24	48	nC	
Reverse Recovery Fall Time	ta	- I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		16		ns	
Reverse Recovery Rise Time	t _b	7		20			

Notes

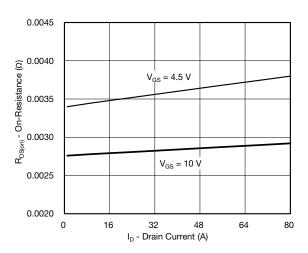
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

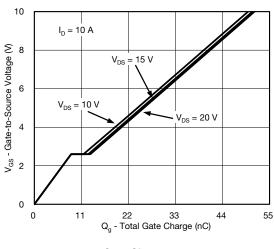




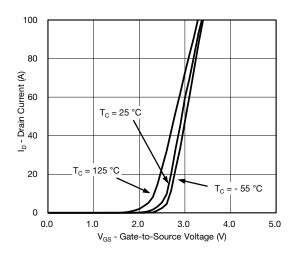
Output Characteristics



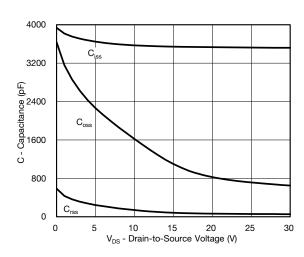
On-Resistance vs. Drain Current



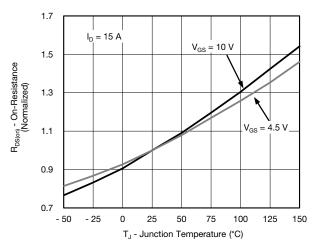
Gate Charge



Transfer Characteristics

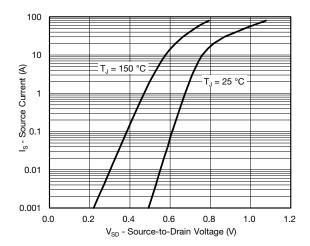


Capacitance

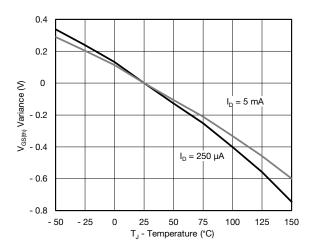


On-Resistance vs. Junction Temperature

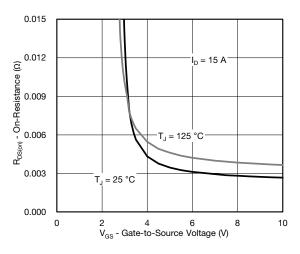




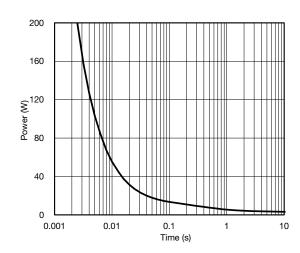
Source-Drain Diode Forward Voltage



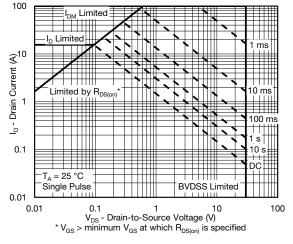
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

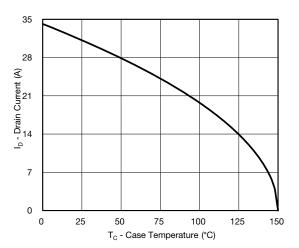


Single Pulse Power, Junction-to-Ambient

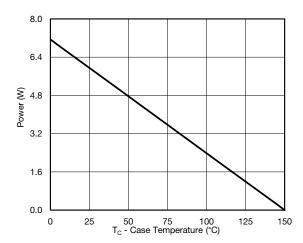


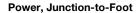
Safe Operating Area, Junction-to-Ambient

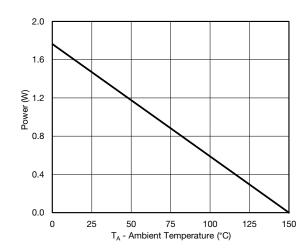




Current Derating*





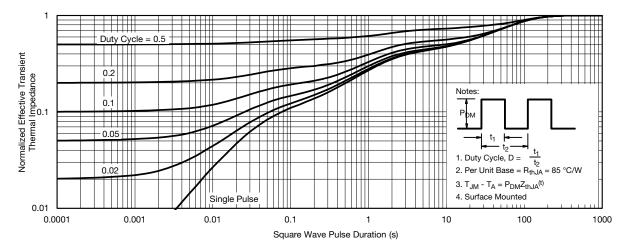


Power, Junction-to-Ambient

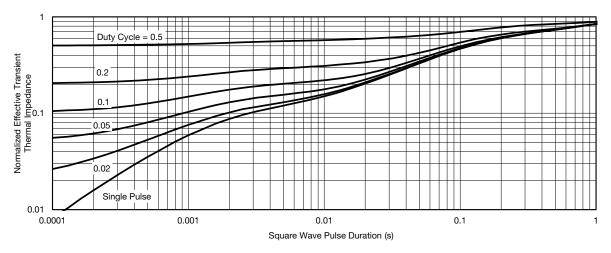
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^{*} The power dissipation P_D is based on T_{J(max.)} = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

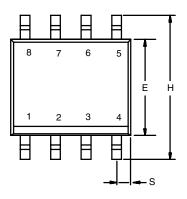


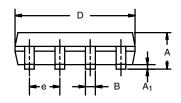
Normalized Thermal Transient Impedance, Junction-to-Foot

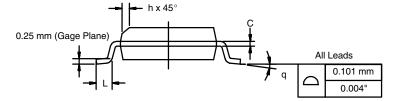
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	HES		
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050	0.050 BSC	
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I. 11-Sep-06					

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

APPLICATION NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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